

Notice of References CitedApplication/Control No.
09/793,213Applicant(s)/Patent Under
Reexamination
MATTSON ET AL.

Examiner

Fred G. Prince

Art Unit

1724

Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-2,329,987	09-1943	Goodloe	
B	US-4,233,694	11-1980	Janosko et al.	
C	US-5,383,239	01-1995	Mathis et al.	
D	US-5,928,510	07-1999	Meredith	
E	US-6,065,161	05-2000	Mateina et al.	
F	US-6,066,253	05-2000	Idland et al.	
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

*	U	
	V	
	W	
	X	

'A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.'J.S. Patent and Trademark Office
PTO-892 (Rev. 01-2001)

Notice of References Cited

Part of Paper No. 8

11/19/04

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/797,837	MATTSON ET AL.	
Examiner		Art Unit	Page 1 of 1	
Tuan N. Nguyen		3751		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-852,044	04-1907	Van Der Minden	4/291
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.